

**Notice of References Cited**

Application/Control No.

10/550,853

Applicant(s)/Patent Under  
Reexamination  
MEUNIER-BEILLARD ET AL.

Examiner

KHIEM D. NGUYEN

Art Unit

2823

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,312,128	12-2007	Kim et al.	438/300
*	B	US-7,101,774	09-2006	Nagasawa et al.	438/478
*	C	US-4,642,227	02-1987	Flagan et al.	423/349
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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